SCLS115B - DECEMBER 1982 - REVISED MAY 1997

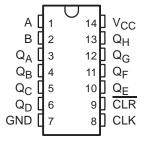
- AND-Gated (Enable/Disable) Serial Inputs
- Fully Buffered Clock and Serial Inputs
- Direct Clear
- Package Options Include Plastic Small-Outline (D) and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

#### description

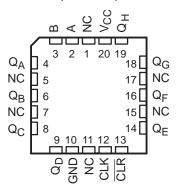
These 8-bit shift registers feature AND-gated serial inputs and an asynchronous clear (CLR) input. The gated serial (A and B) inputs permit complete control over incoming data; a low at either input inhibits entry of the new data and resets the first flip-flop to the low level at the next clock (CLK) pulse. A high-level input enables the other input, which then determines the state of the first flip-flop. Data at the serial inputs can be changed while CLK is high or low, provided the minimum setup time requirements are met. Clocking occurs on the low-to-high-level transition of CLK.

The SN54HC164 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74HC164 is characterized for operation from -40°C to 85°C.

SN54HC164 . . . J OR W PACKAGE SN74HC164 . . . D OR N PACKAGE (TOP VIEW)



SN54HC164 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

#### **FUNCTION TABLE**

	INPU	JTS	OUTPUTS				
CLR	CLK	Α	В	$Q_{A}$	Q <sub>B</sub> .	Q <sub>H</sub>	
L	Х	Χ	Χ	L	L	L	
Н	L	Χ	X	Q <sub>A0</sub>	$Q_{B0}$	Q <sub>H0</sub>	
Н	$\uparrow$	Н	Н	Н	$Q_{An}$	Q <sub>Gn</sub>	
Н	$\uparrow$	L	Χ	L	$Q_{An}$	$Q_{Gn}$	
Н	$\uparrow$	Χ	L	L	$Q_{An}$	$Q_{Gn}$	

 $Q_{A0}$ ,  $Q_{B0}$ ,  $Q_{H0}$  = the level of  $Q_A$ ,  $Q_B$ , or  $Q_H$ , respectively, before the indicated steady-state input conditions were established

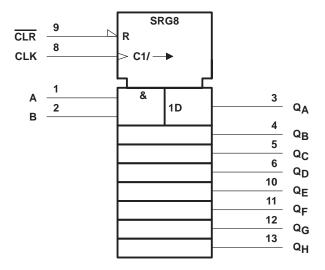
Q<sub>An</sub>, Q<sub>Gn</sub> = the level of Q<sub>A</sub> or Q<sub>G</sub> before the most recent 
↑ transition of CLK: indicates a 1-bit shift



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

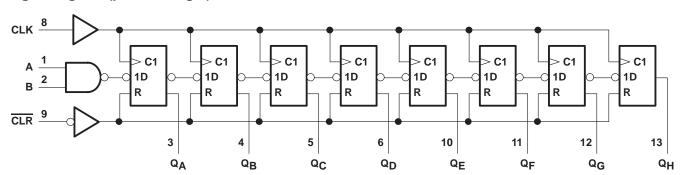


#### logic symbol†



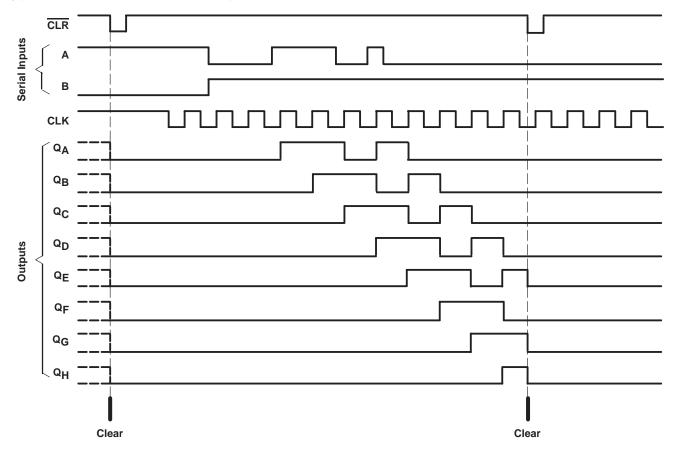
 $<sup>^\</sup>dagger$  This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, N, and W packages.

## logic diagram (positive logic)



Pin numbers shown are for the D, J, N, and W packages.

#### typical clear, shift, and clear sequence



# absolute maximum ratings over operating free-air temperature range<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	0.5 V to 7 V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) (see Note 1)	±20 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> ) (see Note 1)	±20 mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )	±25 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 2): D package	127°C/W
N package	78°C/W
Storage temperature range, T <sub>Stq</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.



## SN54HC164, SN74HC164 8-BIT PARALLEL-OUT SERIAL SHIFT REGISTERS

SCLS115B - DECEMBER 1982 - REVISED MAY 1997

#### recommended operating conditions

			SI	154HC16	64	SN74HC164		4	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		2	5	6	2	5	6	V
		V <sub>CC</sub> = 2 V	1.5			1.5			V
$\vee_{IH}$	/IH High-level input voltage	V <sub>CC</sub> = 4.5 V	3.15			3.15			
		VCC = 6 V	4.2			4.2			
VIL	Low-level input voltage	V <sub>CC</sub> = 2 V	0		0.5	0		0.5	
		V <sub>CC</sub> = 4.5 V	0		1.35	0		1.35	V
		VCC = 6 V	0		1.8	0		1.8	
VI	Input voltage		0		VCC	0		VCC	V
VO	Output voltage		0		VCC	0		VCC	V
		V <sub>CC</sub> = 2 V	0		1000	0		1000	
t <sub>t</sub> †	Input transition (rise and fall) time	V <sub>CC</sub> = 4.5 V	0		500	0		500	ns
		V <sub>CC</sub> = 6 V	0		400	0		400	
TA	Operating free-air temperature		-55		125	-40		85	°C

<sup>†</sup> If this device is used in the threshold region (from V<sub>IL</sub>max = 0.5 V to V<sub>IH</sub>min = 1.5 V), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at t<sub>t</sub> = 1000 ns and V<sub>CC</sub> = 2 V does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS		Vaa	T <sub>A</sub> = 25°C			SN54H	C164	SN74HC164		UNIT
PARAMETER	lesi cc	MUITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		1.9		
VOH VI = VIH or VIL	I <sub>OH</sub> = -20 μA	4.5 V	4.4	4.499		4.4		4.4			
	VI = VIH or VIL		6 V	5.9	5.999		5.9		5.9		V
		$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
		$I_{OH} = -5.2 \text{ mA}$	6 V	5.48	5.8		5.2		5.34		
		I <sub>OL</sub> = 20 μA	2 V		0.002	0.1		0.1		0.1	
			4.5 V		0.001	0.1		0.1		0.1	
VOL	VI = VIH or VIL		6 V		0.001	0.1		0.1		0.1 V	
		I <sub>OL</sub> = 4 mA	4.5 V		0.17	0.26		0.4		0.33	
		$I_{OL} = 5.2 \text{ mA}$	6 V		0.15	0.26		0.4		0.33	
lį	$V_I = V_{CC}$ or 0		6 V		±0.1	±100		±1000		±1000	nA
Icc	$V_I = V_{CC}$ or 0,	IO = 0	6 V			8		160		80	μΑ
Ci			2 V to 6 V		3	10		10		10	pF

SCLS115B - DECEMBER 1982 - REVISED MAY 1997

# timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			V	T <sub>A</sub> =	25°C	SN54F	IC164	SN74F	IC164	UNIT	
			vcc	MIN	MAX	MIN	MAX	MIN	MAX	ONIT	
			2 V	0	6	0	4.2	0	5		
fclock	f <sub>clock</sub> Clock frequency		Clock frequency	4.5 V	0	31	0	21	0	25	MHz
<u> </u>		6 V	0	36	0	25	0	28			
t <sub>W</sub> Pulse duration		2 V	100		150		125				
	CLR low	4.5 V	20		30		25		_		
		6 V	17		25		21				
	Puise duration		2 V	80		120		100		ns	
		CLK high or low	4.5 V	16		24		20			
			6 V	14		20		18			
		Data	2 V	100		150		125			
			4.5 V	20		30		25			
١.	Catura tima hafara CLKA		6 V	17		25		21			
t <sub>su</sub>	Setup time before CLK↑		2 V	100		150		125		ns	
		CLR inactive	4.5 V	20		30		25			
			6 V	17		25		21		1 1	
			2 V	5		5		5			
th	Hold time, data after CLK↑		4.5 V	5		5	·	5		ns	
			6 V	5		5		5			

# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

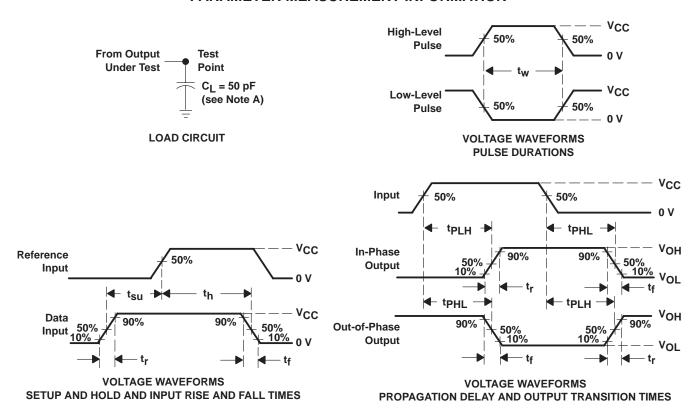
PARAMETER	FROM	то	V	T,	Δ = 25°C	;	SN54H	IC164	SN74H	IC164	UNIT
PARAMETER	(INPUT)	(OUTPUT)	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
			2 V	6	10		4.2		5		
f <sub>max</sub>			4.5 V	31	54		21		25		MHz
			6 V	36	62		25		28		
			2 V		140	205		295		255	
t <sub>PHL</sub>	CLR	Any Q	4.5 V		28	41		59		51	
			6 V		24	35		51		46	ns
			2 V		115	175		265		220	115
t <sub>pd</sub>	CLK	Any Q	4.5 V		23	35		53		44	
			6 V		20	30		45		38	
			2 V		38	75		110		95	
t <sub>t</sub>			4.5 V		8	15		22		19	ns
			6 V		6	13		19		16	

## operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	No load	135	pF



#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.

- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \ \Omega$ ,  $t_r = 6 \ ns$ ,  $t_f = 6 \ ns$ .
- C. For clock inputs,  $f_{\text{max}}$  is measured when the input duty cycle is 50%.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms

#### **IMPORTANT NOTICE**

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.

Copyright © 1998, Texas Instruments Incorporated